Enhanced ESD,3.0 KV rms/5.0 KV rms 200Mbps Dual-channel Digital Isolators

FEATURES

- Ultra-low power consumption (1Mbps): 0.58mA/Channel
- High data rate: 200Mbps
- High common-mode transient immunity:
  - ADuM320x：75kV/μs typical
  - ADuM420x：120kV/μs typical
- High robustness to radiated and conducted noise
- Low propagation delay: 9ns typical
- Isolation voltages:
  - ADUM320x: AC 3000Vrms
  - ADUM420x: AC 5000Vrms
- High ESD rating:
  - ESDA/JEDEC JS-001-2017
  - Human body model (HBM) ±8kV
- Safety and regulatory approvals：
  - 3000Vrms/5000Vrms for 1 minute per UL 1577
  - CSA Component Acceptance Notice 5A
  - DIN VDE V 0884-11:2017-01
  - V_{IORM} =565V peak/1200V peak
  - CQC certification per GB4943.1-2011
- 3 V to 5.5 V level translation
- AEC-Q100 qualification
- Wide temperature range: -40°C to 125°C
- RoHS-compliant, NB SOIC-8, WB SOIC-16 package

APPLICATIONS

- General-purpose multichannel isolation
- Industrial field bus isolation
- Isolation Industrial automation systems
- Isolated switch mode supplies
- Isolated ADC, DAC
- Motor control

FUNCTIONAL BLOCK DIAGRAMS

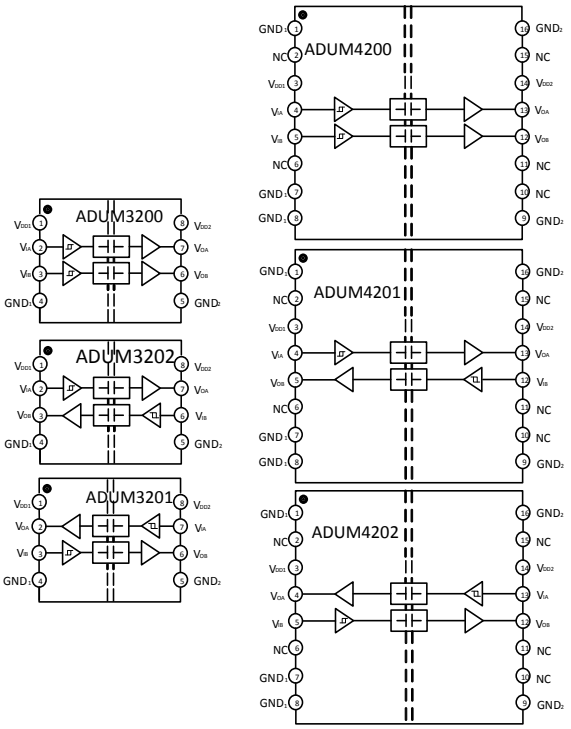

Figure 1. ADUM320x/420x functional Block Diagram

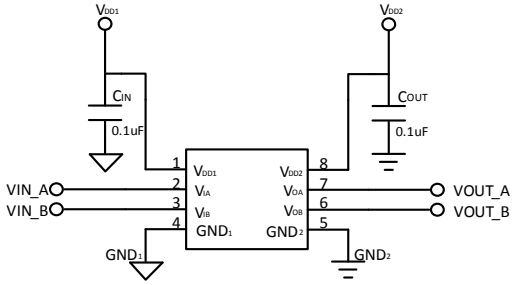

Figure 2. ADUM3201 Typical Application Circuit

PIN CONFIGURATIONS AND FUNCTIONS

Table 1. ADUM3200 Pin Function Descriptions

Pin No.	Name	Description
1	V_{DD1}	Supply Voltage for Isolator Side 1.
2	V_{IA}	Logic Input A.
3	V_{IB}	Logic Input B.
4	GND_1	Ground 1. This pin is the ground reference for Isolator Side 1.
5	GND_2	Ground 2. This pin is the ground reference for Isolator Side 2.
6	V_{OB}	Logic Output B.
7	V_{OA}	Logic Output A.
8	V_{DD2}	Supply Voltage for Isolator Side 2.

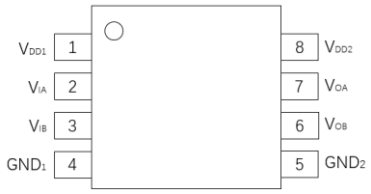

Figure 3. ADUM3200 Pin Configuration

Table 2. ADUM3202 Pin Function Descriptions

Pin No.	Name	Description
1	V_{DD1}	Supply Voltage for Isolator Side 1.
2	V_{IA}	Logic Input A.
3	V_{OB}	Logic Output B.
4	GND_1	Ground 1. This pin is the ground reference for Isolator Side 1.
5	GND_2	Ground 2. This pin is the ground reference for Isolator Side 2.
6	V_{IB}	Logic Input B.
7	V_{OA}	Logic Output A.
8	V_{DD2}	Supply Voltage for Isolator Side 2.

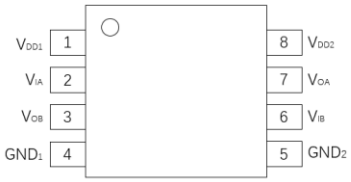

Figure 4. ADUM3202 Pin Configuration

Table 3. ADUM3201 Pin Function Descriptions

Pin No.	Name	Description
1	V_{DD1}	Supply Voltage for Isolator Side 1.
2	V_{OA}	Logic Output A.
3	V_{IB}	Logic Input B.
4	GND_1	Ground 1. This pin is the ground reference for Isolator Side 1.
5	GND_2	Ground 2. This pin is the ground reference for Isolator Side 2.
6	V_{OB}	Logic Output B.
7	V_{IA}	Logic Input A.
8	V_{DD2}	Supply Voltage for Isolator Side 2.

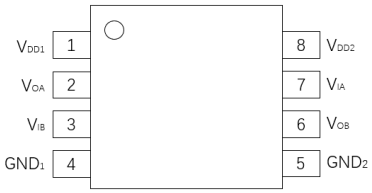

Figure 5. ADUM3201 Pin Configuration

Table 4 ADUM4200 Pin Function Descriptions

Pin No.	Name	Description
1	GND_1	Ground 1. This pin is the ground reference for Isolator Side 1.
2	NC	No connect.
3	V_{DD1}	Supply Voltage for Isolator Side 1.
4	V_{IA}	Logic Input A.
5	V_{IB}	Logic Input B.
6	NC	No Connect.
7	GND_1	Ground 1. This pin is the ground reference for Isolator Side 1.
8	GND_1	Ground 1. This pin is the ground reference for Isolator Side 1.
9	GND_2	Ground 2. This pin is the ground reference for Isolator Side 2.
10	NC	No Connect.
11	NC	No Connect.
12	V_{OB}	Logic Output B.
13	V_{OA}	Logic Output A.
14	V_{DD2}	Supply Voltage for Isolator Side 2.
15	NC	No Connect.
16	GND_2	Ground 2. This pin is the ground reference for Isolator Side 2.

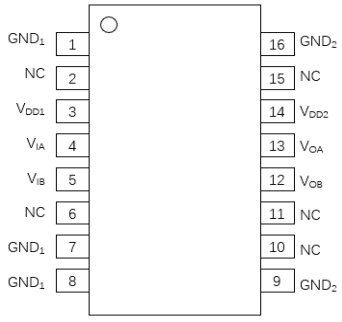

Figure 6. ADUM4200 Pin Configuration

Table 5. ADUM4201 Pin Function Descriptions

Pin No.	Name	Description
1	GND_1	Ground 1. This pin is the ground reference for Isolator Side 1.
2	NC	No Connect.
3	V_{DD1}	Supply Voltage for Isolator Side 1.
4	V_{IA}	Logic Input A.
5	V_{OB}	Logic Output B.
6	NC	No Connect.
7	GND_1	Ground 1. This pin is the ground reference for Isolator Side 1.
8	GND_1	Ground 1. This pin is the ground reference for Isolator Side 1.
9	GND_2	Ground 2. This pin is the ground reference for Isolator Side 2.
10	NC	No Connect.
11	NC	No Connect.
12	V_{IB}	Logic Input B.
13	V_{OA}	Logic Output A.
14	V_{DD2}	Supply Voltage for Isolator Side 2.
15	NC	No Connect.
16	GND_2	Ground 2. This pin is the ground reference for Isolator Side 2.

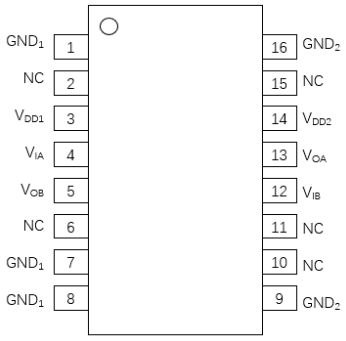

Figure 7. ADUM4201 Pin Configuration

Table 6 ADUM4202 Pin Function Descriptions

Pin No.	Name	Description
1	GND_1	Ground 1. This pin is the ground reference for Isolator Side 1.
2	NC	No Connect.
3	V_{DD1}	Supply Voltage for Isolator Side 1.
4	V_{OA}	Logic Output A.
5	V_{IB}	Logic Input B.
6	NC	No Connect.
7	GND_1	Ground 1. This pin is the ground reference for Isolator Side 1.
8	GND_1	Ground 1. This pin is the ground reference for Isolator Side 1.
9	GND_2	Ground 2. This pin is the ground reference for Isolator Side 2.
10	NC	No Connect.
11	NC	No Connect.
12	V_{OB}	Logic Output B.
13	V_{IA}	Logic Input A.
14	V_{DD2}	Supply Voltage for Isolator Side 2.
15	NC	No Connect.
16	GND_2	Ground 2. This pin is the ground reference for Isolator Side 2.

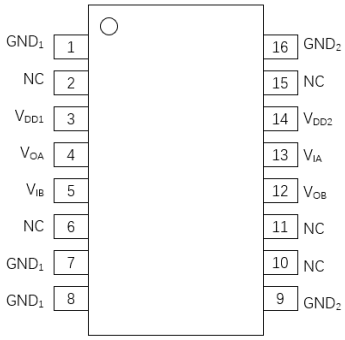

Figure 8. ADUM4202 Pin Configuration

ABSOLUTE MAXIMUM RATINGS

T_A = 25°C, unless otherwise noted.

Table 7.Absolute Maximum Ratings[4]

Parameter	Rating
Supply Voltages (V_{DD1}-GND_1, V_{DD2}-GND_2)	−0.5 V ~ +7.0 V
Input Voltages (V_{IA}, V_{IB})[1]	−0.5 V ~ V_{DDx} + 0.5 V
Output Voltages (V_{OA}, V_{OB})[1]	−0.5 V ~ V_{DDx} + 0.5 V
Average Output Current per Pin[2] Side 1 Output Current (I_{O1})	−10 mA ~ +10 mA
Average Output Current per Pin[2] Side 2 Output Current (I_{O2})	−10 mA ~ +10 mA
Common-Mode Transients Immunity[3]	−200 kV/μs ~ +200 kV/μs
Storage Temperature (T_{ST}) Range	−65°C ~ +150°C
Ambient Operating Temperature (T_A) Range	−40°C ~ +125°C

Notes:

[1] V_{DDx} is the side voltage power supply V_{DD}, where x = 1 or 2.

[2] See Figure 9 for the maximum rated current values for various temperatures.
[3] See Figure 17 for Common-mode transient immunity (CMTI) measurement.
[4] Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

RECOMMENDED OPERATING CONDITIONS

Table 8.Recommended Operating Conditions

Parameter	Symbol	Min	Typ	Max	Unit
Supply Voltage	V_{DDx} [1]	3		5.5	V
High Level Input Signal Voltage	V_{IH}	0.7*V_{DDx}[1]		V_{DDx}[1]	V
Low Level Input Signal Voltage	V_{IL}	0		0.3*V_{DDx}[1]	V
High Level Output Current	I_{OH}	-6			mA
Low Level Output Current	I_{OL}			6	mA
Data Rate		0		200	Mbps
Junction Temperature	T_J	-40		150	°C
Ambient Operating Temperature	T_A	-40		125	°C

Notes:
[1] V_{DDx} is the side voltage power supply V_{DD}, where x = 1 or 2.

Truth Tables

Table 9. ADUM320x/420x Truth Table

V_{Ix} Input[1]	V_{DDI} State[1]	V_{DDO} State[1]	Default Low V_{Ox} Output[1]	Default High V_{Ox} Output[1]	Test Conditions /Comments
Low	Powered[2]	Powered[2]	Low	Low	Normal operation
High	Powered[2]	Powered[2]	High	High	Normal operation
Open	Powered[2]	Powered[2]	Low	High	Default output
Don't Care[4]	Unpowered[3]	Powered[2]	Low	High	Default output[5]
Don't Care[4]	Powered[2]	Unpowered[3]	High Impedance	High Impedance	

Notes:
[1] V_{Ix}/V_{Ox} are the input/output signals of a given channel (A or B). V_{DDI}/V_{DDO} are the supply voltages on the input/output signal sides of this given channel.
[2] Powered means V_{DDx}≥ 2.95 V
[3] Unpowered means V_{DDx} < 2.30V
[4] Input signal (V_{Ix}) must be in a low state to avoid powering the given V_{DDI}[1] through its ESD protection circuitry.
[5] If the V_{DDI} goes into unpowered status, the channel outputs the default logic signal after around 1us. If the V_{DDI} goes into powered status, the channel outputs the input status logic signal after around 3us.

SPECIFICATIONS

ELECTRICAL CHARACTERISTICS

Table 10. ADUM320x Switching Specifications

V_{DD1} - V_{GND1} = V_{DD2} - V_{GND2} = 3.3V_{DC}±10% or 5V_{DC}±10%, T_A=25°C, unless otherwise noted.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
Minimum Pulse Width	PW			5	ns	Within pulse width distortion (PWD) limit
Maximum Data Rate		200			Mbps	Within PWD limit
Propagation Delay Time[1]	t_{pHL}, t_{pLH}	5.5	8	12.5	ns	@ 5V_{DC} supply
		6.5	9	13.5	ns	@ 3.3V_{DC} supply
Pulse Width Distortion	PWD		0.3	3.0	ns	The max different time between t_{pHL} and t_{pLH}@ 5V_{DC} supply. And The value is | t_{pHL} - t_{pLH} |
			0.4	3.0	ns	The max different time between t_{pHL} and t_{pLH}@ 3.3V_{DC} supply. And The value is | t_{pHL} - t_{pLH} |

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
Part to Part Propagation Delay Skew	t_{PSK}			2	ns	The max different propagation delay time between any two devices at the same temperature, load and voltage @ $5V_{DC}$ supply
				2	ns	The max different propagation delay time between any two devices at the same temperature, load and voltage @ $3.3V_{DC}$ supply
Channel to Channel Propagation Delay Skew	t_{CSK}		0	1.8	ns	The max amount propagation delay time differs between any two output channels in the single device @ $5V_{DC}$ supply.
			0	2	ns	The max amount propagation delay time differs between any two output channels in the single device @ $3.3V_{DC}$ supply
Output Signal Rise/Fall Time[4]	t_r/t_f		1.5		ns	See Figure 13.
Dynamic Input Supply Current per Channel	$I_{DDI (D)}$		9		μA /Mbps	Inputs switching, 50% duty cycle square wave, CL = 0 pF @ $5V_{DC}$ Supply
Dynamic Output Supply Current per Channel	$I_{DDO (D)}$		38		μA /Mbps	
Dynamic Input Supply Current per Channel	$I_{DDI (D)}$		5		μA /Mbps	Inputs switching, 50% duty cycle square wave, CL = 0 pF @ $3.3V_{DC}$ Supply
Dynamic Output Supply Current per Channel	$I_{DDO (D)}$		23		μA /Mbps	
Common-Mode Transient Immunity[3]	CMTI		75		kV/μs	$V_{IN} = V_{DDx}$[2] or 0V, V_{CM} = 1000 V.
Jitter			120		ps p-p	See the Jitter Measurement section
			20		ps rms	
ESD(HBM - Human body model)	ESD		±8		kV	

Notes:

[1] t_{pLH} = low-to-high propagation delay time, t_{pHL} = high-to-low propagation delay time. See Figure 14.

[2] V_{DDx} is the side voltage power supply V_{DD}, where x = 1 or 2.

[3] See Figure 17 for Common-mode transient immunity (CMTI) measurement.

[4] t_r means is the time from 10% amplitude to 90% amplitude of the rising edge of the signal , t_f means is the time from 90% amplitude to 10% amplitude of the falling edge of the signal.

Table 11. ADUM420x Switching Specifications

$V_{DD1} - V_{GND1} = V_{DD2} - V_{GND2} = 3.3V_{DC}$±10% or $5V_{DC}$±10%, T_A=25°C, unless otherwise noted.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
Minimum Pulse Width	PW			5	ns	Within pulse width distortion (PWD) limit
Maximum Data Rate		200			Mbps	Within PWD limit
Propagation Delay Time[1]	t_{pHL}, t_{pLH}		12	16	ns	@ $5V_{DC}$ supply
			14	18.5	ns	@ $3.3V_{DC}$ supply
Pulse Width Distortion	PWD		0.3	3.0	ns	The max different time between t_{pHL} and t_{pLH}@ $5V_{DC}$ supply. And The value is $\lvert t_{pHL} - t_{pLH} \rvert$
			0.4	3.0	ns	The max different time between t_{pHL} and t_{pLH}@ $3.3V_{DC}$ supply. And The value is $\lvert t_{pHL} - t_{pLH} \rvert$
Part to Part Propagation Delay Skew	t_{PSK}			2	ns	The max different propagation delay time between any two devices at the same temperature, load and voltage @ $5V_{DC}$ supply
				2	ns	The max different propagation delay time between any two devices at the same temperature, load and voltage @ $3.3V_{DC}$ supply

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
Channel to Channel Propagation Delay Skew	t_{CSK}		0	1.8	ns	The max amount propagation delay time differs between any two output channels in the single device @ $5V_{DC}$ supply.
			0	2	ns	The max amount propagation delay time differs between any two output channels in the single device @ $3.3V_{DC}$ supply
Output Signal Rise/Fall Time[4]	t_r/t_f		1.5		ns	See Figure 13.
Dynamic Input Supply Current per Channel	$I_{DDI (D)}$		10		μA /Mbps	Inputs switching, 50% duty cycle square wave, CL = 0 pF @ $5V_{DC}$ Supply
Dynamic Output Supply Current per Channel	$I_{DDO (D)}$		45		μA /Mbps	
Dynamic Input Supply Current per Channel	$I_{DDI (D)}$		9		μA /Mbps	Inputs switching, 50% duty cycle square wave, CL = 0 pF @ $3.3V_{DC}$ Supply
Dynamic Output Supply Current per Channel	$I_{DDO (D)}$		28		μA /Mbps	
Common-Mode Transient Immunity[3]	CMTI		120		kV/μs	$V_{IN} = V_{DDx}$[2] or 0V, V_{CM} = 1000 V.
Jitter			180		ps p-p	See the Jitter Measurement section
			30		ps rms	
ESD(HBM - Human body model)	ESD		±8		kV	

Notes:

[1] t_{pLH} = low-to-high propagation delay time, t_{pHL} = high-to-low propagation delay time. See Figure 14.

[2] V_{DDx} is the side voltage power supply V_{DD}, where x = 1 or 2.

[3] See Figure 17 for Common-mode transient immunity (CMTI) measurement.

[4] t_r means is the time from 10% amplitude to 90% amplitude of the rising edge of the signal , t_f means is the time from 90% amplitude to 10% amplitude of the falling edge of the signal.

Table 12.DC Specifications

$V_{DD1} - V_{GND1} = V_{DD2} - V_{GND2} = 3.3V_{DC}$±10% or $5V_{DC}$±10%, T_A=25°C, unless otherwise noted.

Parameter	Symbol	Min	Typ	Max	Unit	Test Conditions/Comments
Rising Input Signal Voltage Threshold	V_{IT+}		0.6*V_{DDx}[1]	0.7*V_{DDx}[1]	V	
Falling Input Signal Voltage Threshold	V_{IT-}	0.3* V_{DDx}[1]	0.4* V_{DDx}[1]		V	
High Level Output Voltage	V_{OH} [1]	V_{DDx} – 0.1	V_{DDx}		V	−20 μA output current
		V_{DDx} – 0.2	V_{DDx} – 0.1		V	−2 mA output current
Low Level Output Voltage	V_{OL}		0	0.1	V	20 μA output current
			0.1	0.2	V	2 mA output current
Input Current per Signal Channel	I_{IN}	−10	0.5	10	μA	0 V ≤ Signal voltage ≤ V_{DDx}[1]
V_{DDx}[1] Undervoltage Rising Threshold	V_{DDxUV+}	2.45	2.75	2.95	V	
V_{DDx}[1] Undervoltage Falling Threshold	V_{DDxUV-}	2.30	2.60	2.75	V	
V_{DDx}[1] Hysteresis	V_{DDxUVH}		0.15		V	

Notes:

[1] V_{DDx} is the side voltage power supply V_{DD}, where x = 1 or 2.

Table 13.Quiescent Supply Current

$V_{DD1} - V_{GND1} = V_{DD2} - V_{GND2} = 3.3V_{DC}$±10% or $5V_{DC}$±10%, T_A=25°C, C_L = 0 pF, unless otherwise noted.

Part	Symbol	Min	Typ	Max	Unit	Test Conditions	
						Supply voltage	Input signal
ADUM3200ARZ	$I_{DD1 (Q)}$	0.06	0.08	0.10	mA	$5V_{DC}$	VI=0V for ADuMxxxx0
	$I_{DD2 (Q)}$	0.78	0.98	1.27	mA		VI=5V for ADuMxxxx1
	$I_{DD1 (Q)}$	0.16	0.20	0.26	mA		VI=5V for ADuMxxxx0

Part	Symbol	Min	Typ	Max	Unit	Test Conditions	
						Supply voltage	Input signal
	$I_{DD2\ (Q)}$	0.74	0.92	1.20	mA		VI=0V for ADuMxxxx1
	$I_{DD1\ (Q)}$	0.06	0.08	0.10	mA	$3.3V_{DC}$	VI=0V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.77	0.97	1.26	mA		VI=3.3V for ADuMxxxx1
	$I_{DD1\ (Q)}$	0.12	0.15	0.19	mA		VI=3.3V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.71	0.89	1.15	mA		VI=0V for ADuMxxxx1
ADUM3202ARZ	$I_{DD1\ (Q)}$	0.42	0.52	0.68	mA	$5V_{DC}$	VI=0V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.42	0.52	0.68	mA		VI=5V for ADuMxxxx1
	$I_{DD1\ (Q)}$	0.44	0.55	0.71	mA		VI=5V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.44	0.55	0.71	mA		VI=0V for ADuMxxxx1
	$I_{DD1\ (Q)}$	0.41	0.52	0.67	mA	$3.3V_{DC}$	VI=0V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.41	0.52	0.67	mA		VI=3.3V for ADuMxxxx1
	$I_{DD1\ (Q)}$	0.41	0.51	0.66	mA		VI=3.3V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.41	0.51	0.66	mA		VI=0V for ADuMxxxx1
ADUM3201ARZ	$I_{DD1\ (Q)}$	0.42	0.52	0.68	mA	$5V_{DC}$	VI=0V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.42	0.52	0.68	mA		VI=5V for ADuMxxxx1
	$I_{DD1\ (Q)}$	0.44	0.55	0.71	mA		VI=5V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.44	0.55	0.71	mA		VI=0V for ADuMxxxx1
	$I_{DD1\ (Q)}$	0.41	0.52	0.67	mA	$3.3V_{DC}$	VI=0V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.41	0.52	0.67	mA		VI=3.3V for ADuMxxxx1
	$I_{DD1\ (Q)}$	0.41	0.51	0.66	mA		VI=3.3V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.41	0.51	0.66	mA		VI=0V for ADuMxxxx1
ADUM4200ARZ	$I_{DD1\ (Q)}$	0.06	0.10	0.13	mA	$5V_{DC}$	VI=0V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.78	1.12	1.46	mA		VI=5V for ADuMxxxx1
	$I_{DD1\ (Q)}$	0.16	0.32	0.41	mA		VI=5V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.74	1.03	1.35	mA		VI=0V for ADuMxxxx1
	$I_{DD1\ (Q)}$	0.06	0.10	0.12	mA	$3.3V_{DC}$	VI=0V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.77	1.09	1.42	mA		VI=3.3V for ADuMxxxx1
	$I_{DD1\ (Q)}$	0.12	0.21	0.27	mA		VI=3.3V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.71	1.01	1.30	mA		VI=0V for ADuMxxxx1
ADUM4201ARZ	$I_{DD1\ (Q)}$	0.42	0.60	0.78	mA	$5V_{DC}$	VI=0V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.42	0.60	0.78	mA		VI=5V for ADuMxxxx1
	$I_{DD1\ (Q)}$	0.44	0.66	0.85	mA		VI=5V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.44	0.66	0.85	mA		VI=0V for ADuMxxxx1
	$I_{DD1\ (Q)}$	0.41	0.58	0.74	mA	$3.3V_{DC}$	VI=0V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.41	0.58	0.74	mA		VI=3.3V for ADuMxxxx1
	$I_{DD1\ (Q)}$	0.41	0.59	0.77	mA		VI=3.3V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.41	0.59	0.77	mA		VI=0V for ADuMxxxx1
ADUM4202ARZ	$I_{DD1\ (Q)}$	0.42	0.60	0.78	mA	$5V_{DC}$	VI=0V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.42	0.60	0.78	mA		VI=5V for ADuMxxxx1
	$I_{DD1\ (Q)}$	0.44	0.66	0.85	mA		VI=5V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.44	0.66	0.85	mA		VI=0V for ADuMxxxx1
	$I_{DD1\ (Q)}$	0.41	0.58	0.74	mA	$3.3V_{DC}$	VI=0V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.41	0.58	0.74	mA		VI=3.3V for ADuMxxxx1
	$I_{DD1\ (Q)}$	0.41	0.59	0.77	mA		VI=3.3V for ADuMxxxx0
	$I_{DD2\ (Q)}$	0.41	0.59	0.77	mA		VI=0V for ADuMxxxx1

Table 14.Total Supply Current vs. Data Throughput (CL = 0 pF)

V_{DD1} - V_{GND1} = V_{DD2} - V_{GND2} = $3.3V_{DC}$±10% or $5V_{DC}$±10%, T_A=25°C, C_L = 0 pF, unless otherwise noted.

Part	Symbol	2 Mbps			20 Mbps			200 Mbps			Unit	Supply voltage
		Min	Typ	Max	Min	Typ	Max	Min	Typ	Max		
ADUM3200ARZ	I_{DD1}		0.23	0.36		0.48	0.77		3.72	5.95	mA	$5V_{DC}$
	I_{DD2}		1.12	1.80		2.64	4.22		17.20	27.52		
	I_{DD1}		0.16	0.25		0.36	0.58		2.16	3.46	mA	$3.3V_{DC}$
	I_{DD2}		1.07	1.71		2.15	3.43		11.14	17.82		
ADUM3202ARZ	I_{DD1}		0.64	1.02		1.94	3.10		10.40	16.64	mA	$5V_{DC}$
	I_{DD2}		0.64	1.02		1.94	3.10		10.40	16.64		
	I_{DD1}		0.59	0.95		1.54	2.46		6.58	10.53	mA	$3.3V_{DC}$
	I_{DD2}		0.59	0.95		1.54	2.46		6.58	10.53		
ADUM3201ARZ	I_{DD1}		0.64	1.02		1.94	3.10		10.40	16.64	mA	$5V_{DC}$
	I_{DD2}		0.64	1.02		1.94	3.10		10.40	16.64		
	I_{DD1}		0.59	0.95		1.54	2.40		6.58	10.53	mA	$3.3V_{DC}$
	I_{DD2}		0.59	0.95		1.54	2.40		6.58	10.53		
ADUM4200ARZ	I_{DD1}		0.33	0.53		1.06	1.70		8.78	14.05	mA	$5V_{DC}$
	I_{DD2}		1.28	2.04		2.93	4.68		19.54	31.26		
	I_{DD1}		0.22	0.35		0.68	1.09		5.16	8.26	mA	$3.3V_{DC}$
	I_{DD2}		1.21	1.94		2.39	3.82		13.28	21.25		
ADUM4201ARZ	I_{DD1}		0.77	1.23		2.54	4.06		14.92	23.87	mA	$5V_{DC}$
	I_{DD2}		0.77	1.23		2.54	4.06		14.92	23.87		
	I_{DD1}		0.69	1.11		1.98	3.17		9.88	15.81	mA	$3.3V_{DC}$
	I_{DD2}		0.69	1.11		1.98	3.17		9.88	15.81		
ADUM4202ARZ	I_{DD1}		0.77	1.23		2.54	4.06		14.92	23.87	mA	$5V_{DC}$
	I_{DD2}		0.77	1.23		2.54	4.06		14.92	23.87		
	I_{DD1}		0.69	1.11		1.98	3.17		9.88	15.81	mA	$3.3V_{DC}$
	I_{DD2}		0.69	1.11		1.98	3.17		9.88	15.81		

INSULATION AND SAFETY RELATED SPECIFICATIONS

Table 15.Insulation Specifications

Parameter	Symbol	Value		Unit	Test Conditions/Comments
		ADUM320x	ADUM420x		
Rated Dielectric Insulation Voltage		3000	5000	V rms	1-minute duration
Minimum External Air Gap (Clearance)	L (CLR)	≥4	≥8	mm	Measured from input terminals to output terminals, shortest distance through air
Minimum External Tracking (Creepage)	L (CRP)	≥4	≥8	mm	Measured from input terminals to output terminals, shortest distance path along body
Minimum Internal Gap (Internal Clearance)		≥11	≥21	µm	Insulation distance through insulation
Tracking Resistance (Comparative Tracking Index)	CTI	>400	>400	V	
Material Group		II	II		

PACKAGE CHARACTERISTICS

Table 16.Package Characteristics

Parameter	Symbol	Typical Value		Unit	Test Conditions/Comments
		ADUM320x	ADUM420x		
Resistance (Input to Output)[1]	R_{IO}	10^{11}	10^{11}	Ω	
Capacitance (Input to Output)[1]	C_{IO}	1.5	1.5	pF	@1MHz
Input Capacitance[2]	C_I	3	3	pF	@1MHz
IC Junction to Ambient Thermal Resistance	θ_{JA}	100	45	°C/W	Thermocouple located at center of package underside

Notes:

[1]The device is considered a 2-terminal device; Short-circuit all terminals on the VDD1 side as one terminal, and short-circuit all terminals on the VDD2 side as the other terminal.

[2]Testing from the input signal pin to ground.

DIN V VDE V 0884-11 (VDE V 0884-11) INSULATION CHARACTERISTICS

Table 17.VDE Insulation Characteristics

Description	Test Conditions/Comments	Symbol	Characteristic		Unit
			ADUM320x	ADUM420x	
Installation Classification per DIN VDE 0110					
For Rated Mains Voltage ≤ 150 V rms			I to IV	I to IV	
For Rated Mains Voltage ≤ 300 V rms			I to III	I to III	
For Rated Mains Voltage ≤ 400 V rms			I to III	I to III	
Climatic Classification			40/105/21	40/105/21	
Pollution Degree per DIN VDE 0110, Table 1			2	2	
Maximum repetitive peak isolation voltage		V_{IORM}	565	1200	V peak
Input to Output Test Voltage, Method B1	$V_{IORM} \times 1.5 = V_{pd\,(m)}$, 100% production test, $t_{ini} = t_m = 1$ sec, partial discharge < 5 pC	$V_{pd\,(m)}$	848	1800	V peak

Input to Output Test Voltage, Method A After Environmental Tests Subgroup 1	$V_{IORM} \times 1.3 = V_{pd(m)}$, t_{ini} = 60 sec, t_m = 10 sec, partial discharge < 5 pC	$V_{pd(m)}$	735	1560	V peak
After Input and/or Safety Test Subgroup 2 and Subgroup 3	$V_{IORM} \times 1.2 = V_{pd(m)}$, t_{ini} = 60 sec, t_m = 10 sec, partial discharge < 5 pC	$V_{pd(m)}$	678	1440	V peak
Highest Allowable Overvoltage		V_{IOTM}	4200	7071	V peak
Surge Isolation Voltage Basic	Basic insulation, 1.2/50 µs combination wave, VTEST = 1.3 × VIOSM (qualification)	V_{IOSM}	3615	5000	V peak
Safety Limiting Values	Maximum value allowed in the event of a failure (see *Figure 9*)				
Maximum safety Temperature		T_S	150	150	℃
Maximum Power Dissipation at 25°C		P_S	1.25	2.78	W
Insulation Resistance at T_S	V_{IO} = 500 V	R_S	>10^9	>10^9	Ω

Typical Thermal Characteristic

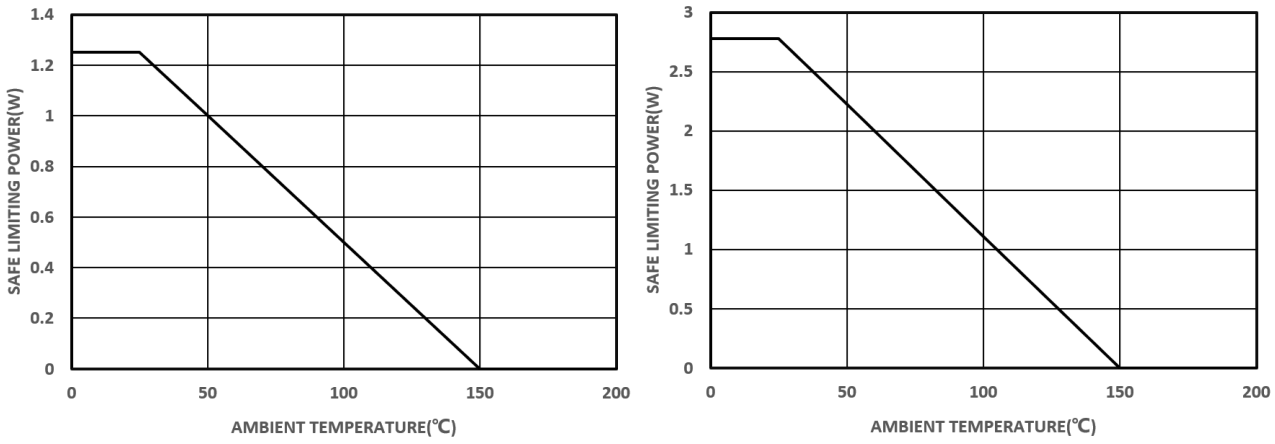

Figure 9.Thermal Derating Curve, Dependence of Safety Limiting Values with Ambient Temperature per VDE (left:M320x ; right: M420x)

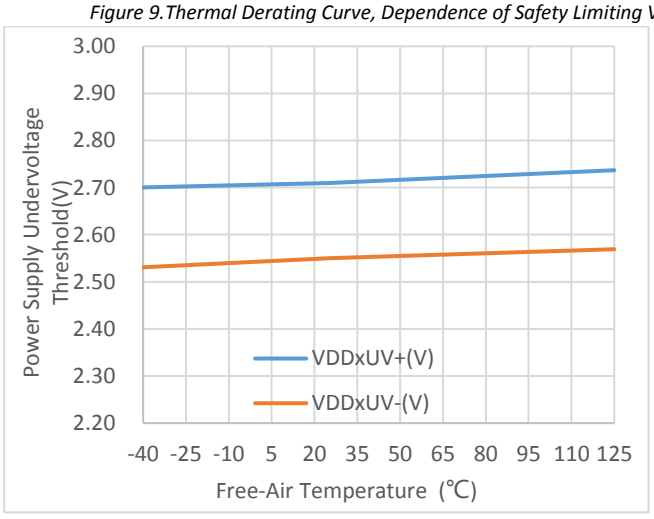

Figure 10.UVLO vs. Free-Air Temperature

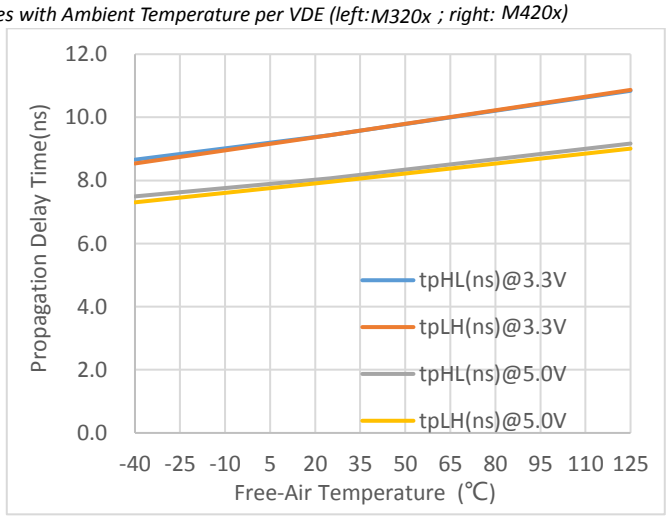

Figure 11. M320x Propagation Delay Time vs. Free-Air Temperature

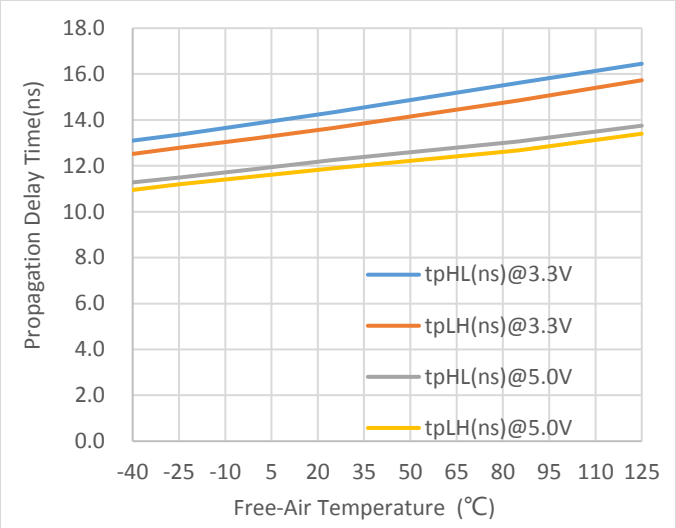

Figure 12. M420x Propagation Delay Time vs. Free-Air Temperature

Timing test information

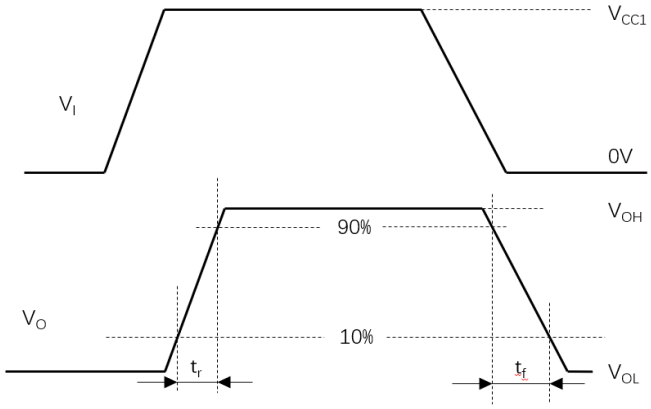

Figure 13.Transition time waveform measurement

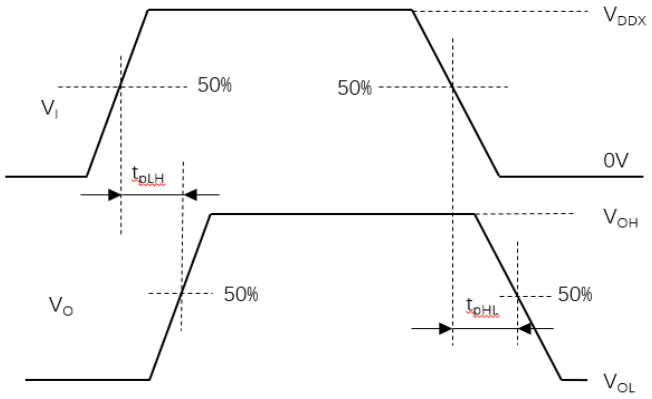

Figure 14. Propagation delay time waveform measurement

PCB LAYOUT

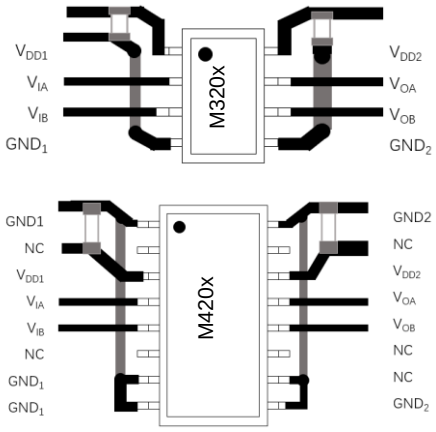

Figure 15.Recommended Printed Circuit Board Layout

The low-ESR ceramic bypass capacitors must be connected between V_{DD1} and GND_1 and between V_{DD2} and GND_2. The bypass capacitors are placed on the PCB as close to the isolator device as possible. The recommended bypass capacitor value is between 0.1 µF and 10 µF. The user may also include resistors (50–300 Ω) in series with the

inputs and outputs if the system is excessively noisy, or in order to enhance the anti ESD ability of the system.

Avoid reducing the isolation capability, Keep the space underneath the isolator device free from metal such as planes, pads, traces and vias.

To minimize the impedance of the signal return loop, keep the solid ground plane directly underneath the high-speed signal path, the closer the better. The return path will couple between the nearest ground plane to the signal path. Keep suitable trace width for controlled impedance transmission lines interconnect.

To reduce the rise time degradation, keep the length of input/output signal traces as short as possible, and route low inductance loop for the signal path and It's return path.

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To reduce the rise time degradation, keep the length of input/output signal traces as short as possible, and route low inductance loop for the signal path and It's return path.

JITTER MEASUREMENT

The eye diagram shown in the figure below provides the jitter measurement result for the ADUM320XARZ/430xARZ . The Keysight 81160A pulse function arbitrary generator works as the data source for the ADUM320XARZ/430xARZ, which generates 100Mbps pseudo random bit sequence (PRBS). The Keysight DSOS104A digital storage oscilloscope captures the ADUM320XARZ/430xARZ output waveform and recoveries the eye diagram with the SDA jitter tools and eye diagram analysis tools. The result shows a typical measurement jitter data.

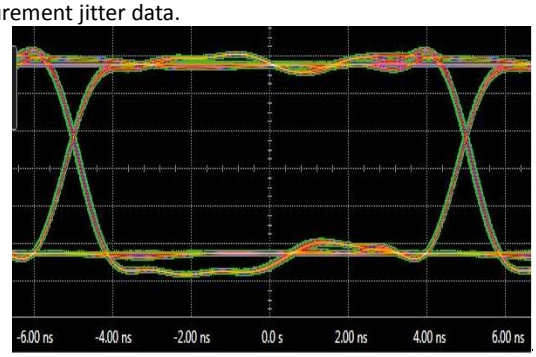


Figure 16. ADUM320x/420x Eye Diagram

CMTI MEASUREMENT

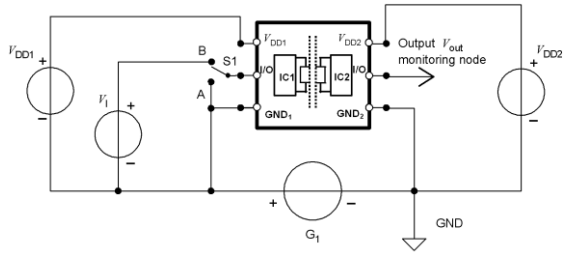


Figure 17.Common-mode transient immunity (CMTI) measurement

To measure the Common-Mode Transient Immunity (CMTI) of Mxxxxx isolator under specified common-mode pulse magnitude (VCM) and specified slew rate of the common-mode pulse (dVCM/dt) and other specified test or ambient conditions, The common-mode pulse generator (G1) will be capable of providing fast rise and fall pulses of specified magnitude and duration of the common-mode pulse (VCM),such that the maximum common-mode slew rates (dVCM/dt) can be applied to Mxxxxx isolator coupler under measurement. The common-mode pulse is applied between one side ground GND1 and the other side ground GND2 of Mxxxxx isolator, and shall be capable of providing positive transients as well as negative transients.

OUTLINE DIMENSIONS

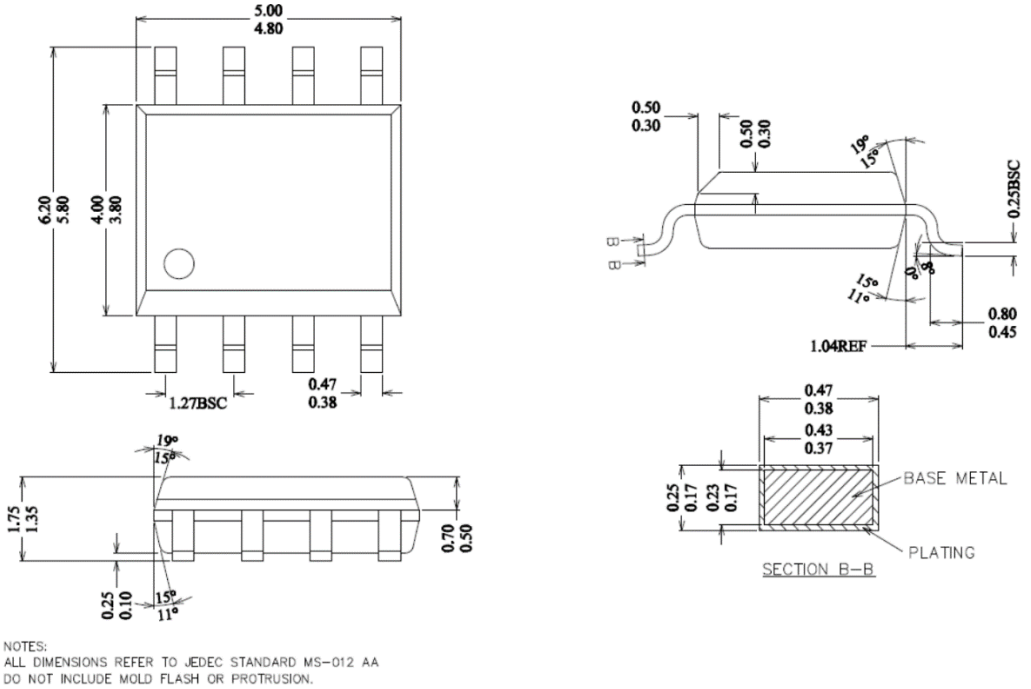
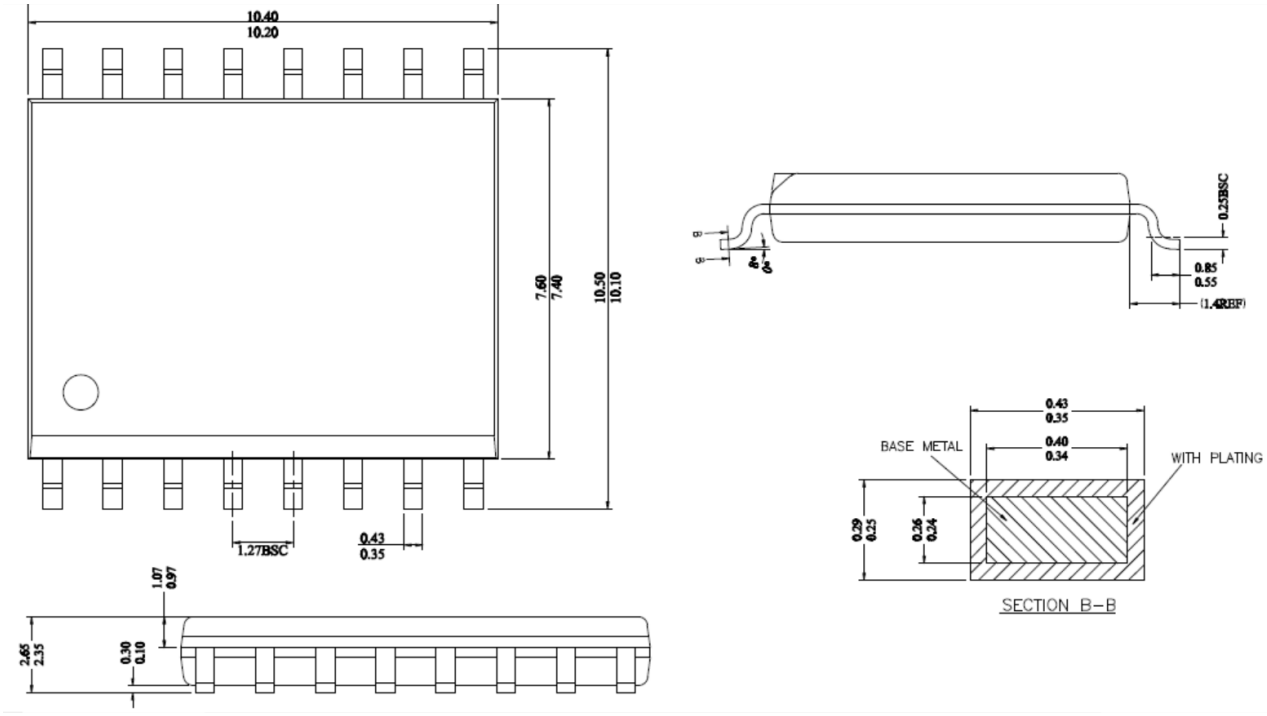


Figure 18. 8-Lead Narrow Body SOIC [NB SOIC-8] *Outline Package–dimension unit(mm)*



Notes:

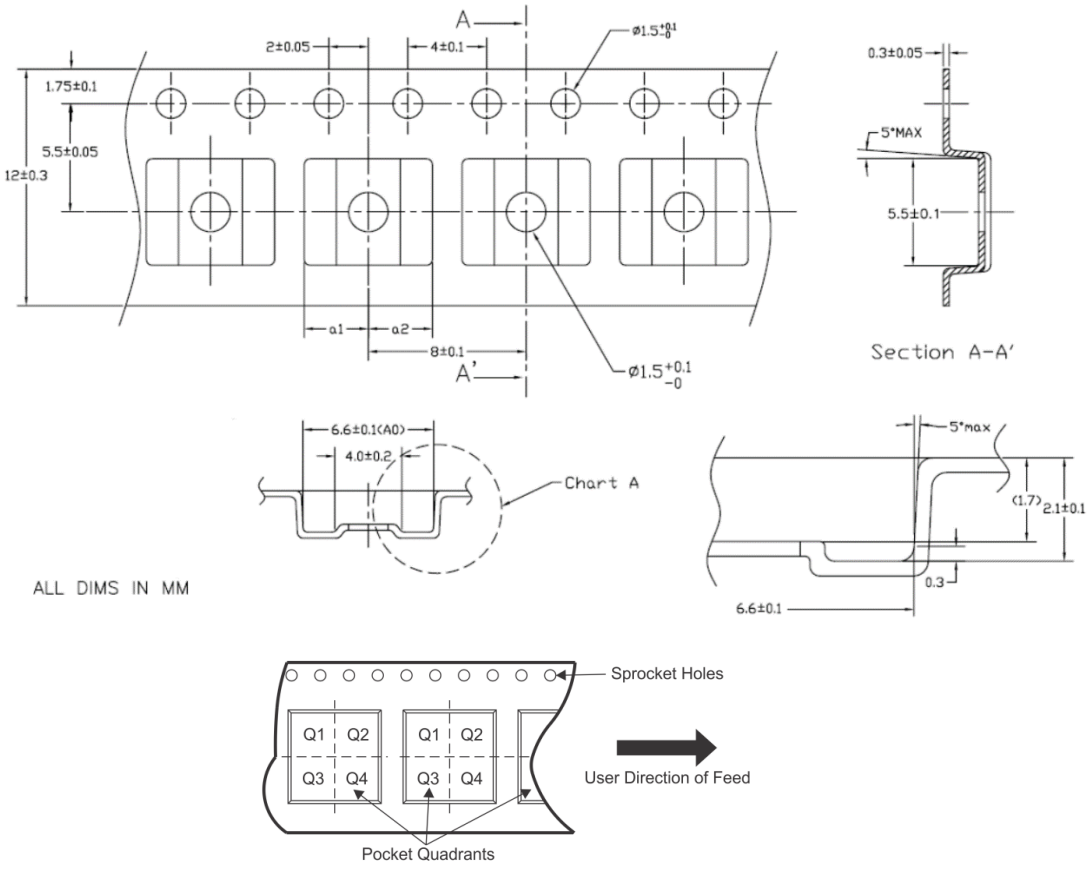
ALL DIMENSIONS MEET JEDEC STANDARD MS-013 AA

DO NOT INCLUDE MOLD FLASH OR PROTRUSION.

Figure 19.16-Lead Wide Body SOIC [WB SOIC-16] *Outline Package –dimension unit(mm)*

REEL INFORMATION

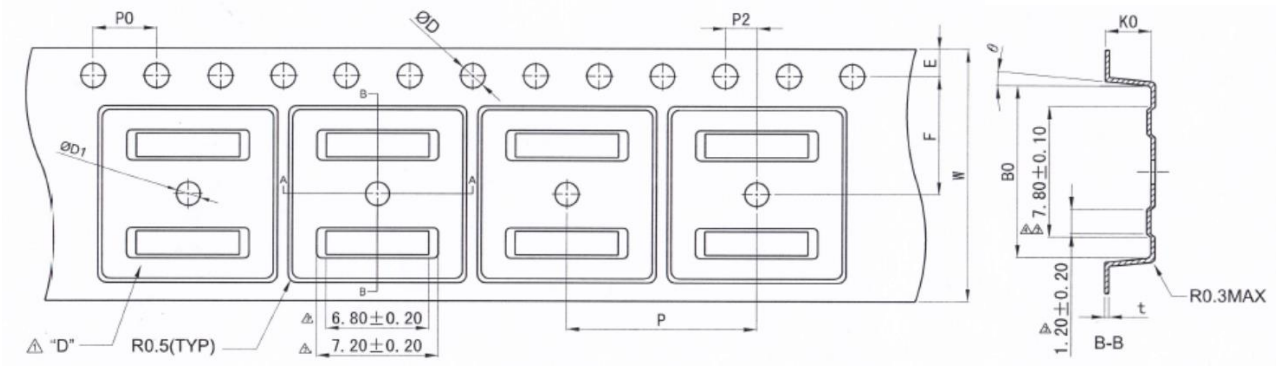
8-Lead Narrow Body SOIC [NB SOIC-8]

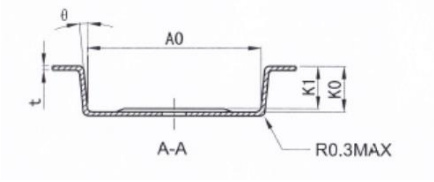


Note： The Pin 1of the chip is in the quadrant Q1

Figure 23. 8-Lead Narrow Body SOIC [NB SOIC-8] Reel Information–*dimension unit(mm)*

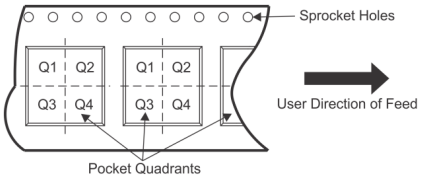
16-Lead Wide Body SOIC [WB SOIC-16]





Items	Size(mm)
E	1.75±0.10
F	7.50±0.05
P2	2.00±0.05
D	1.55±0.05
D1	1.5±0.10
P0	4.00±0.10
10P0	40.00±0.20

Items	Size(mm)
W	16.00±0.30
P	12.00±0.10
A0	10.90±0.10
B0	10.80±0.10
K0	3.00±0.10
t	0.30±0.05
K1	2.70±0.10
θ	5° TYP



Note： The Pin 1 of the chip is in the quadrant Q1

Figure 24. 16-Lead Wide Body SOIC [WB SOIC-16] Reel Information